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| FORM PTO-1449/A and B (Modified) | | APPLICATION NO.: 10/766,298 | ATTY. DOCKET NO.: S1404.70004US01 |
| INFORMATION DISCLOSURE STATEMENT BY APPLICANT | | FILING DATE: January 27, 2004 | CONFIRMATION NO.: Not Yet Assigned |
| | | APPLICANT: David Spencer | |
| | | GROUP ART UNIT: Not Yet Assigned | EXAMINER: Not Yet Assigned |
| Sheet | I | of | 2 |

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| Sheet | 2 | of | 2 | | |

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PTO/SB/08a/b (07-05)

Approved for use through 07/31/2008. OMB 0651-0031

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| Substitute for form 1449A/B/PTO INFORMATION DISCLOSURE STATEMENT BY APPLICANT (Use as many sheets as necessary) | | | | Complete if Known | |
| | | | | Application Number | 10/766298-Conf. #9344 |
| | | | | Filing Date | January 27, 2004 |
| | | | | First Named Inventor | Edward J. Sommer, Jr. |
| | | | | Art Unit | 3654 |
| | | | | Examiner Name | T. H. Matthews |
| Sheet | 1 | of | 1 | Attorney Docket Number | S1404.70004US01 |

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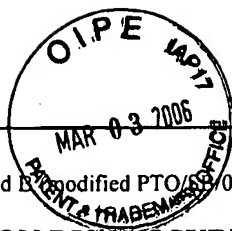
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| Examiner Signature | | Date Considered | 8/17/07 |
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FORM PTO-1449/A and B (modified PTO/688/08)

**INFORMATION DISCLOSURE
STATEMENT BY APPLICANT**

APPLICATION NO.: 10/776,298

ATTY. DOCKET NO.: S1404.70004US01

FILING DATE: January 27, 2004

CONFIRMATION NO.: 9344

APPLICANT: Edward J. Sommer, et al.

GROUP ART UNIT: 3654

EXAMINER: T.H. Matthews

Sheet

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of

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